

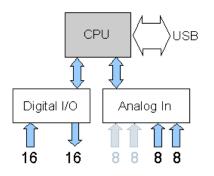
### xDAP 7420

### **Features**

- · Self-contained, with USB connectivity to host
- 8 analog-to-digital converter devices clocked simultaneously
- 1 million samples per second capture on each converter
- 8 million samples per second sustainable aggregate capture
- 8 million samples per second sustainable USB transfer rate
- 16 multiplexed analog differential input channels
- Optional expansion panels for BNC input connectors
- 16-bit resolution on each channel, no missing codes
- Input voltages ranges from ± 0.1 to ± 10.0 volts
- Superior measurement repeatability > 14 ENOB
- CE and 50Hz compliant for European applications
- Programmable sampling interval at resolution 0.02 microseconds
- Autonomous sampling controlled by 2 GHz Intel® processor
- Onboard storage for a minute of buffered data at maximum rates
- Script-configurable through onboard DAPL 3000 operating system

(1) Intel is a trademark of the Intel Corporation.

# **Block Diagram**







xDAP 7420 Specifications Sections: Physical | Processor | Timing | Input | Digital I/O | Input Electrical | Dynamic

# **Physical Characteristics**

Length, body         Image: state	Parameter	Sym	Min	Тур	Max	Units
Length. body         Image: State of the state of t						
Length, body plus handles         (31.6)         (cm)           Length, body plus handles         14.25         (36.2)         (m)           Width         9.25         (23.5)         (m)           Height, body         1         5.25         (13.3)         (m)           Height, body plus feet         1         5.56         (m)         (m)           Weight         1         5.56         (m)         (m)           Operating temperature <sup>(1)</sup> Ta         0         -         50         "C           External AC Power Requirements         VPa         100         -         50         VRMS (230Y)           Supply input voltage <sup>(2)</sup> Vpa         100         50         0         ARMS (115Y)           Supply input current         ba         57         50         53         42           Supply input current         ba         7         50         53         42           Supply input fequency <sup>(4)</sup> fpa         47         50         53         53         42	Enclosure	-				
Image: Constraint of the state of	Length, body					
Width         (36.2)         (cm)           Width         9.25         in         in           Height, body         1         5.25         in         in           Height, body         1         5.26         in         in           Height, body         1         5.26         in         in           Height, body         1         5.66         in         in           Weight         1         5.66         in         in           Operating temperature <sup>(1)</sup> Ta         0         -         50         'C           External AC Power Requirements         Ta         00         -         50         'C           Supply input voltage <sup>(2)</sup> Vps         100         115         240         VRMS           Supply input current         Ips         10         50         Weight (15V)           Supply input power <sup>(3)</sup> Pps         10         50         Weight (23V)           Supply input power <sup>(3)</sup> Pps         10         50         Signal         ARMS (115V)           Supply input frequency <sup>(4)</sup> Ips         47         60         Signal         Signal         Hz						
Leight, body         Image: constraint of the system o	Length, body plus handles					
Height, body       Image: Constraint of the section of	Width					
Height, body plus feet(13.3)(cm)Height, body plus feet15.56in (cm)Weight11.7511.751b (Kg)Operating temperature (1)Ta0-50External AC Power RequirementsSupply input voltage (2)Vps100 -115 230240VRMS V RMSSupply input voltage (2)Vps100 -115 230240VRMS V RMSSupply input currentlps6 3A RMS (115V) A RMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6053 63HzInternal DC power capacityInternal DC power capacity				(23.5)		(cm)
Weight       Image: Image	Height, body					
Weight       Image: Image	Height body plus feet			5 56		in
Operating temperature (1)Ta0-50°CExternal AC Power RequirementsSupply input voltage (2)Vps100 -115 230-VRMS VRMSSupply input currentlps100 6 3ARMS (115V) ARMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6063 63HzInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacity	neight, body plus leet					
Operating temperature (1)Ta050°CExternal AC Power RequirementsSupply input voltage (2)Vps100 -115 230 240V RMS V RMSSupply input currentlps -6 3A RMS (115V) A RMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6053 63HzInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacity	Weight					
External AC Power Requirements         Supply input voltage <sup>(2)</sup> Vps       100       115        240       V RMS         Supply input current       lps        6       3       A RMS (115V)         Supply input power <sup>(3)</sup> Pps       10       50       100       W         Supply input frequency <sup>(4)</sup> fps       47       50       63       42         Internal DC power capacity				(5.5)		(\vg)
Supply input voltage (2)Vps100 -115 230-V RMS 240V RMSSupply input currentlps6 3A RMS (115V) A RMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6053 63HzInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacity	Operating temperature <sup>(1)</sup>	Та	0	_	50	°C
Supply input voltage (2)Vps100 -115 230-V RMS 240V RMSSupply input currentlps6 3A RMS (115V) A RMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6053 63HzInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacity						
Supply input currentIps230240V RMSSupply input power (3)Ips6A RMS (115V) A RMS (230V)Supply input power (3)Pps1050100WSupply input frequency (4)fps47 5750 6053 63HzInternal DC power capacityInternal DC power capacityInternal DC power capacityInternal DC power capacity	External AC Power Requirements	1	· (	I		
Supply input power <sup>(3)</sup> Pps     10     50     100     W       Supply input frequency <sup>(4)</sup> fps     47 57     50 60     53 63     Hz	Supply input voltage <sup>(2)</sup>	V <sub>ps</sub>			240	
Supply input power <sup>(3)</sup> Pps     10     50     100     W       Supply input frequency <sup>(4)</sup> fps     47 57     50 60     53 63     Hz	Querch instant surrent					
Supply input frequency <sup>(4)</sup> fps     47     50     53     Hz       Internal DC power capacity     Internal DC power capacity     Internal DC power capacity     Internal DC power capacity	Supply input current	lps				A RMS (115V) A RMS (230V)
Internal DC power capacity	Supply input power <sup>(3)</sup>	P <sub>ps</sub>	10	50	100	w
Internal DC power capacity	(4)	f	47	50	53	H7
	Supply input frequency (**	ips	57	60	63	112
Continuous ground current load capacity 100 mA	Internal DC power capacity					
	Continuous ground current load capacity				100	mA
Fuse rating, +5V supply 2	Fuse rating, +5V supply			2		
Fuse rating, digital gnd     2     A       Fuse rating, digital+5V     2	Fuse rating, digital gnd Fuse rating, digital+5V			2		A

Presumes adequate ventilation.
 The full range from 100 to 240 volts is tested.
 Does not include loading from added termination networks or customizations.
 Min and max frequency limits are the tested range, nominal value ± 6% tolerance

### **Processor Module**

Feature	Property
Processor type	Intel® Celeron 575
Processor clock speed	2.0 GHz
Processor main memory	1.0 GB
Embedded operating system	DAPL 3000

# **Timing Characteristics**

Parameter	Sym	Min	Тур	Мах	Units
Sampling interval resolution	Δts		20		ns
Sampling interval range	ts	0.5		10000.0	μs
Timing absolute accuracy <sup>(1)</sup>		50	_	50	PPM
Sampling interval jitter		_	100	_	ps
Acquisition latency <sup>(2)</sup>		_	_	900	ns

Oscillator is affected by temperature, supply, and long-term drift variations.
 Describes hardware performance only. Buffering, processing, and data transport contribute much larger latencies.

# **Input Characteristics**

Feature	Property
Analog input channel type	Differential
Number of analog-to-digital converters <sup>(1)</sup>	8 (simultaneous)
Maximum multiplexed analog input signals	32
Primary HD connector	16 channels
Optional BNC input panels	8 or 16 channels
Analog-to-digital converter codes	65536 (16 bits)
Skipped or missing codes	none
Skipped or missing samples	none
Configurable input ranges	7

-10 V to +10 V	gain 1
-5 V to +5 V	gain 2
-2 V to +2 V	gain 5
-1 V to +1 V	gain 10
-0.5 V to +0.5 V	gain 20
-0.2 V to +0.2 V	gain 50
-0.1 V to +0.1 V	gain 100

(1) Conversion operations on all converters are clocked simultaneously.

# Digital I/O Characteristics

Parameter	Sym	Min	Тур	Мах	Units		
Inputs							
Digital Input Ports: 1 (Asynchronous, 16 Input lines each)							
Absolute input range limits		-0.5		5.5	V		
Operating range	Vi	0.0		5.0	v		
Input for level-low	ViL			0.8	V		
Input for level-high	ViH	2.0			v		
Input current <sup>(1)</sup>	h	-12	_	12	μA		
Input load <sup>(1)</sup>	Ri Ci		10 120		kΩ pF		
Input transition time <sup>(2)</sup>	Tt			60	ns		
Outputs Digital Output Ports: 1 (Asynchronous, 16 output lines each)							
Output voltage range	Vo	0		3.3	v		
Continuous output current	lo	-5		5	mA		
Output voltage at -5 mA load	V <sub>оН</sub>	2.4			V		
Output voltage at 5 mA load	V <sub>oL</sub>			0.4	V		
Output termination <sup>(1)</sup>	RT	_	10	_	kΩ		
Output capacitive load <sup>(3)</sup>	CL			200	pF		
Unloaded switching transition time	t <sub>pd</sub>		12	_	ns		
Loaded switching transition time <sup>(4)</sup>	t <sub>pdL</sub>		30	_	ns		
Output voltage source							
Output supply voltage	V <sub>ss</sub>	_	5.0	_	v		

Regulation under full load	ΔV <sub>ss</sub>	-5	+5	%
Supply current	I <sub>SS</sub>		0.5	A
Ground sink current	lG		-0.5	A

The termination resistance is present at all times, and will pull voltages to ground under unpowered conditions.
 Signal transitions between V<sub>iL</sub> and V<sub>iH</sub> levels can go more slowly, but slower transitions could lead to uncertainty in captured value.

(3) Excessive capacitive loading can degrade device stability.
 (4) Includes C<sub>L</sub> capacitive loading in addition to termination.

## **Input Electrical Characteristics**

Sym	Min	Тур	Max	Units			
Input channels							
ViMax	-35		+35	v			
Vi	-13		+13	v			
R <sub>i</sub> Ci	_	20 50	_	MΩ pF			
۱ <u>L</u>	_	5	46	nA			
	_	0.4	_	pC			
	-2	_	2	counts			
	_	_	_	μV / °C			
	_	_	_	% / yr			
	_	_	0.05	%			
	_	_	_	% / °C			
	_	_	_	% / yr			
	_	20	_	V / µs			
	V <sub>iMax</sub> V <sub>i</sub> R <sub>i</sub> C <sub>i</sub>	ViMax       -35         Vi       -13         Ri          IL          -2          -2          -1          -2          -35          -10          -2          -35	ViMax       -35         Vi       -13         Ri          Ci          L          JL          -2          -1          -2          -1          -1          -2          -1      <	VIMax       -35       +35         Vi       -13       +13 $R_i$ -       20 $C_i$ -       20 $I_L$ -       50 $I_L$ -       5 $I_L$ -       0.4         -       -       2 $I_L$ -       - $I_L$ -       0.4         -       -       2 $I_L$ -       - $I_L$ -       0.4         -       -       - $I_L$ -       - $I_L$ -       0.4         -       -       - $I_L$			

(1) For accurate measurements through the full differential measurement range, the common mode must be restricted to the Common Mode Voltage Range (CMVR), a subset of the maximum operating range. The CMVR equals the maximum operating range minus the configured differential range; in effect, this reserves half of the differential input range near each (2) This injection occurs each time a multiplexer device captures a new sample.

(a) this injection of the set of

# **Dynamic Response Characteristics**

Parameter	Sym	Min	Тур	Max	Units
Range -10V to +10V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise <sup>(1) (2)</sup>		_	0.58	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	90	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-90	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	87	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB	_	14.1	_	bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	92	_	dB
Nonlinearity Error (Integral Noninearity)	INL			1.2	count
Common Mode Rejection Ratio at DC	CMRR0	_	-98	_	dB
Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	—	-92	_	dB
Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-88	_	dB
Range -5V to +5V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise (1) (2)		_	0.60	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	89	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-94	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	88	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB	_	14.3	_	bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	98	_	dB
Nonlinearity Error (Integral Noninearity)	INL			1.3	count
Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-103	_	dB

Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-92	_	dB
Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-92	_	dB
Range -2V to +2V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise <sup>(1) (2)</sup>		_	0.70	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	85	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-95	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	85	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB	_	13.8	_	bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	98	_	dB
Nonlinearity Error (Integral Noninearity)	INL			1.4	count
Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-110	_	dB
Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-92	_	dB
Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-92	—	dB
Range -1V to +1V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise <sup>(1) (2)</sup>		_	0.91	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	87	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-91	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	86	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB		12.8		bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	97	_	dB
Nonlinearity Error (Integral Noninearity)	INL			1.5	count
Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-110	_	dB

Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-92	_	dB
Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-92	_	dB
Range -0.5V to +0.5V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise $^{(1)}$ $^{(2)}$		_	2.6	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	79	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-91	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	78	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB	_	12.8	_	bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	93	_	dB
Nonlinearity Error (Integral Noninearity)	INL			1.6	count
Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-110	_	dB
Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-85	_	dB
Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-85	_	dB
Range -0.2V to +0.2V					
Theoretical quantization noise <sup>(1)</sup>			0.57		count
Static ground noise <sup>(1) (2)</sup>		_	4.5	_	count
Signal to Noise Ratio <sup>(3)</sup>	SNR	_	74	_	dB
Total Harmonic Distortion <sup>(3)</sup>	THD	_	-91	_	dB
Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	74	_	dB
Effective Number of Bits <sup>(3)</sup>	ENOB	_	12.1	_	bits
Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	86	_	dB
Nonlinearity Error (Integral Noninearity)	INL			2.2	count
Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-110	_	dB

Common Mode Rejection Ratio at 60 HzCMRR00-80-dBCommon Mode Rejection Ratio at 10 kHzCMRR10k-80-dBRange -0.1V to +0.1V80-dBTheoretical quantization noise <sup>(1)</sup> -0.57countStatic ground noise <sup>(1)</sup> (2)-7.6-countSignal to Noise Ratio <sup>(3)</sup> SNR-70-dBTotal Harmonic Distortion <sup>(3)</sup> SINAD-70-dBSignal to Noise-and-Distortion <sup>(3)</sup> SINAD-70-dBEffective Number of Bits <sup>(3)</sup> ENOB-11.4-bitsSpurious-Free Dynamic Range <sup>(4)</sup> SFDR-80-dBNonlinearity Error (Integral Noninearity)NL2.6countCommon Mode Rejection Ratio at 00 HzCMRR076-dBCommon Mode Rejection Ratio at 60 HzCMRR076-dBCommon Mode Rejection Ratio at 10 kHzCMRR10k76-dB						
Range -0.1V to +0.1V         Theoretical quantization noise <sup>(1)</sup> 0.57       count         Static ground noise <sup>(1)</sup> (2)       -       7.6       -       count         Signal to Noise Ratio <sup>(3)</sup> SNR       -       70       -       d8         Total Harmonic Distortion <sup>(3)</sup> THD       -       -91       -       d8         Signal to Noise-and-Distortion <sup>(3)</sup> SINAD       -       70       -       d8         Effective Number of Bits <sup>(3)</sup> ENOB       -       11.4       -       bits         Spurious-Free Dynamic Range <sup>(4)</sup> SFDR       -       80       -       d8         Nonlinearity Error (Integral Noninearity)       NL       2.8       count         Common Mode Rejection Ratio at DC       CMRR <sub>60</sub> -       -       d8	Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-80	_	dB
Theoretical quantization noise <sup>(1)</sup> Image: Constant of the second s	Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-80	_	dB
Static ground noise (1) (2)       -       7.6       -       count         Signal to Noise Ratio (3)       SNR       -       70       -       dB         Total Harmonic Distortion (3)       THD       -       -91       -       dB         Signal to Noise-and-Distortion (3)       SINAD       -       70       -       dB         Effective Number of Bits (3)       SINAD       -       70       -       dB         Spurious-Free Dynamic Range (4)       SFDR       -       80       -       dB         Nonlinearity Error (Integral Noninearity)       INL       Image: 2.6       count         Common Mode Rejection Ratio at DC       CMRR <sub>60</sub> -       -       -       dB	Range -0.1V to +0.1V					
Signal to Noise Ratio (3)SNR-70-dBTotal Harmonic Distortion (3)THD91-dBSignal to Noise-and-Distortion (3)SINAD-70-dBEffective Number of Bits (3)SINAD-70-dBSpurious-Free Dynamic Range (4)SFDR-80-dBNonlinearity Error (Integral Noninearity)INL2.6countCommon Mode Rejection Ratio at DCCMRR <sub>60</sub> 110-dBCommon Mode Rejection Ratio at 60 HzCMRR <sub>60</sub> 76-dB	Theoretical quantization noise <sup>(1)</sup>			0.57		count
Total Harmonic Distortion (3)THD91dBSignal to Noise-and-Distortion (3)SINAD70dBEffective Number of Bits (3)ENOB11.4bitsSpurious-Free Dynamic Range (4)SFDR80dBNonlinearity Error (Integral Noninearity)INLIntegral2.6countCommon Mode Rejection Ratio at DCCMRR0110dBCommon Mode Rejection Ratio at 60 HzCMRR6076dB	Static ground noise <sup>(1) (2)</sup>		_	7.6	_	count
Signal to Noise-and-Distortion (3)SINAD-70-dBEffective Number of Bits (3)ENOB-11.4-bitsSpurious-Free Dynamic Range (4)SFDR-80-dBNonlinearity Error (Integral Noninearity)INLI2.6countCommon Mode Rejection Ratio at DCCMRR0110-dBCommon Mode Rejection Ratio at 60 HzCMRR6076-dB	Signal to Noise Ratio <sup>(3)</sup>	SNR	_	70	_	dB
Effective Number of Bits <sup>(3)</sup> ENOB       -       11.4       -       bits         Spurious-Free Dynamic Range <sup>(4)</sup> SFDR       -       80       -       dB         Nonlinearity Error (Integral Noninearity)       INL       -       2.6       count         Common Mode Rejection Ratio at DC       CMRR0       -       -110       -       dB         Common Mode Rejection Ratio at 60 Hz       CMRR60       -       -76       -       dB	Total Harmonic Distortion <sup>(3)</sup>	THD	_	-91	_	dB
Spurious-Free Dynamic Range <sup>(4)</sup> SFDR        80        dB         Nonlinearity Error (Integral Noninearity)       INL       Inc       2.6       count         Common Mode Rejection Ratio at DC       CMRR0        -110        dB         Common Mode Rejection Ratio at 60 Hz       CMRR60        -76        dB	Signal to Noise-and-Distortion <sup>(3)</sup>	SINAD	_	70	_	dB
Nonlinearity Error (Integral Noninearity)       INL       Image: Common Mode Rejection Ratio at DC       CMRR0        -110        dB         Common Mode Rejection Ratio at 60 Hz       CMRR60        -76        dB	Effective Number of Bits <sup>(3)</sup>	ENOB	_	11.4	_	bits
Common Mode Rejection Ratio at DC     CMRR0    110      dB       Common Mode Rejection Ratio at 60 Hz     CMRR60      -76     -     dB	Spurious-Free Dynamic Range <sup>(4)</sup>	SFDR	_	80	_	dB
Common Mode Rejection Ratio at 60 Hz     CMRR <sub>60</sub>	Nonlinearity Error (Integral Noninearity)	INL			2.6	count
	Common Mode Rejection Ratio at DC	CMRR <sub>0</sub>	_	-110	_	dB
Common Mode Rejection Ratio at 10 kHz CMRR <sub>10k</sub> — -76 — dB	Common Mode Rejection Ratio at 60 Hz	CMRR <sub>60</sub>	_	-76	_	dB
	Common Mode Rejection Ratio at 10 kHz	CMRR <sub>10k</sub>	_	-76	_	dB

(1) Noise levels are given as RMS (standard deviation), where one unit corresponds to one LSB count of the converter. (2) Quiescent noise is measured with constant input level, nominally held at 0 V through 0  $\Omega$  resistance, ignoring offset. (3) Repeatability tests use 10 kHz, sinusoidal excitation with amplitude > -0.5 dB relative to full converter range,

and sampling rate is  $2 \times 10^5$  samples per second.

(4) Same as repeatability tests but sampling at  $1.0 \times 10^6$  samples per second.

### Terminology

#### Decibel

A logarithmic representation for the ratio of signal power in two signals. For each incremental increase of 10 decibels, the ratio increases by a power of 10. For each incremental decrease of 10 decibels, the ratio decreases by a power of 10.

#### Differential

A measurement scheme using an input amplifier having two balanced inputs, a *plus input* and a *minus input*. The amplifier responds in proportion to the difference between the plus input and minus input signals.

#### Common Mode

Voltages presented to the inputs of a differential amplifier can be decomposed into two parts, a *common mode* component that is halfway between the two input voltages, and a balanced *differential mode* component that is added or subtracted from the *common mode* component. When both inputs of a differential amplifier are connected to the same voltage signal, the amplifier is said to be driven *in common mode*. The ideal response of a differential amplifier to the common mode input component is zero.

#### Common Mode Rejection (Common Mode Rejection Ratio, CMRR)

The ratio of the signal power in the response of a differential amplifier driven in *common mode* to the signal power that would be observed when measuring the signal in a normal differential configuration.

#### Multiplexed Sampling

Analog to digital converters operate in a *multiplexed configuration* when multiple input signals are selected in succession by a digitally-controlled analog switch, and routed to an analog-to-digital converter. This strategy allows hardware devices to process more signal channels, but with the disadvantage that a longer sampling time interval is typically necessary to allow settling time after each switching transient.

#### Expansion

A strategy employed by Microstar Laboratories to increase the number of signal channels available with multiplexed sampling.

#### **Resolution** (Quantization)

The number of bits available to represent a digitally captured analog signal. The first bit is able to resolve the range into two parts: the positive half and the negative half. The next bit can resolve each of these halves into two parts, an upper and lower part. Continuing this process, N bits resolve the input range into  $2^N$  distinct and equally-spaced sub-ranges.

#### Full Range

For a converter that can produce N distinct output codes, *full range* is used somewhat interchangeably to mean the full set of possible output codes, or the corresponding differential input voltage swing required to cover all of these output codes.

#### Dynamic Range

The range of signal levels that can be distinguished from the low-level noise floor. (See Signal to Noise Ratio.)

#### Conversion ratio

The ratio of the number of converter output codes to the input voltage range required to produce them. The *ideal* conversion ratio is the ratio of the number of converter output codes to the nominal input voltage range. The *actual* conversion ratio is the observed number of output codes divided by the voltage range that produces them. For a perfect conversion, the converter output values will exactly equal the input differential voltage times the ideal conversion ratio.

#### Offset Error (bias)

With a differential amplifier input driven in common mode, a consistent nonzero measurement is an offset error. Calibration is effective for nulling offset errors.

#### Gain Error

After correcting for offsets, the *gain error* is the difference between an observed conversion ratio and the ideal conversion ratio, normalized by the ideal conversion ratio. Calibration is effective for correcting gain errors.

#### Nonlinearity Error (Integral Nonlinearity Error, INL)

Nonlinearity error can be considered the component of digitization error that does not arise from random effects. After making a best correction for gain and offset errors, any non-random differences between actual conversion results and the results predicted by the conversion ratio are *nonlinearity errors*. Because the converter must quantize the measurement according to the number of available bits of resolution, a nonlinearity error of at least 0.5 bits is unavoidable.

#### Ground Noise (Static Noise, Background Noise, Noise Floor)

Random effects in conversion results reflect the combined effects of quantum noise in devices, radio frequency interference, and so forth. Noise effects cause a significant portion of the errors observed in digitized measurements. *Static* or *quiescent* noise is observed by measuring a steady reference voltage during periods of relative inactivity. *Dynamic ground noise*, also called *background noise* or *noise floor*, is observed during periods of intensive sampling activity in the presence of changing high-level input signals.

#### Signal to Noise Ratio (SNR)

The ratio of the signal power in a full-range sinusoidal input signal to the total power in the dynamic background noise. This is a measure of how much random effects interfere with measurement accuracy in each sample. It is a best-case estimate; background noise effects tend to remain about the same level while the signal power drops significantly as the magnitude of the signal is reduced below full scale.

#### Harmonic Frequencies (Harmonic Distortion)

Applying a nonlinear function to a pure sinusoidal input signal results in a distorted signal having additional frequencies at twice the original signal frequency, three times the original signal frequency, and so forth. The introduced frequencies are called *harmonics*.

#### Total Harmonic Distortion (THD)

With an input converter driven by a full-range sinusoidal input signal, total harmonic distortion is the ratio of the signal power in the sinusoidal input signal to the total signal power in the harmonic frequencies resulting from nonlinearity.

### Spurious-Free Dynamic Range (SFDR)

With an input converter driven by a full-range sinusoidal input signal, the *spurious-free dynamic range* is the ratio of the sinusoidal input signal power to the signal power at any other frequency having the next-highest signal power. Most often, the spurious frequency is one of the harmonic frequencies caused by nonlinearity. Since the THD measurement includes several harmonic frequencies, but SFDR only includes one, the SFDR figures tends to be slightly higher.

#### Signal to Noise+Distortion Ratio (SINAD)

SINAD is ratio of the signal power in a full-range sinusoidal input signal to the total power in all other frequencies resulting from the conversion process. This is similar to SNR, except that the signal power in the harmonics is included along with the background noise. SINAD provides an estimate of measurement errors to expect from consistent and random effects in combination.

#### Effective Number of Bits (ENOB)

ENOB is an equivalent way to present SINAD in terms of powers of 2 and "bits" rather than decibels. An ENOB of 14 bits for a 16 bit converter can be loosely interpreted as meaning that variations can be expected in the last 2 bits of each conversion due to nonlinearity and random effects. Accuracy can be extended beyond the levels suggested by ENOB, however, if measurements are repeatable and averaging can be applied to reduce the random effects.

#### Settling Time (Transient Response)

When using multiplexed inputs or dedicated inputs subjected to large step transients, the drive current and bandwidth limitations of amplifiers prevent tracking of instantaneous step edges. *Settling time* describes the length of sampling interval  $t_s$  that should be allowed to give the conversion circuits time to reach the correct values within acceptable accuracy.

#### Slewing (Rate Limiting)

A condition in which an input amplifier is subjected to a large input level change and uses all available current internally for driving its output stage. This results in a fast *linear* ramp output behavior, rather than tracking the input change accurately. Sinusoidal waveforms with sufficiently large magnitude and frequency will be distorted if the time derivative of the waveform exceeds the slew rate limit.

#### Jitter

Variability in the times at which discrete events takes place. Jitter causes uncertainty about which precise moments a signal sample is captured or a switching event is detected.

#### Hold Time

The amount of time that a signal must be held at a constant level to be sure that other circuits will respond reliably.

#### Setup Time

An amount of time that must be allowed after sending a signal for changes to take effect.

#### Latency

A delay in receiving the results of a conversion. For example, a sample might require 1 microsecond to be transported from the converter device, 2 milliseconds to be moved to buffer memory, and 25 milliseconds to be transferred to host memory. The delays for receiving the data typically do not matter unless it is important to respond very quickly.

#### Crosstalk

A side effect of stray coupling between signal lines, resulting in small measurement changes that increase apparent correlation between signals measured on the lines. Such effects are typically introduced by capacitive and inductive coupling between lines that are physically close in cabling and on circuit boards.

#### Charge injection

An amount of charge capacitively coupled into converter inputs each time a signal is captured. Though the effects of each charge injection are very small, when the device is clocked at a very high rate, the cumulative effects act like a current flow, interacting with the input circuit impedance and producing an observable shift in the measurements of input signals.

#### Charge cross-injection

A contributor to crosstalk resulting from multiplexer operation. When connected to one line, stray capacitances at the switching device charge up to balance with the line voltage. When switched to a new signal source, the voltage on this capacitance is temporarily out of balance with the new line, causing a very small but rapid surge in charge until voltages again equalize. With poorly conditioned input signals, the effects can be amplified by high impedances and stray dynamics. The effects are greatest when multiplexer switching occurs at a high rate.

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